FORM PTO-1449 U.S. DEPARTMENT OF COMMERCE (Modified)

PATENT AND TRADEMARK OF TO

INFORMATION DISCLOSURE (Use several sheets if necessary) STATEMENT BY APPLICANT

(37 CFR 1.98(b))

ATTY.DOCKET NO. 1662-27800 (P00-3105) SERIAL NO. 09/652,834

APPLICANTS Michael S. BERTONE et al.

FILING DATE August 31, 2000

GROUP 2152

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Examiner Initial		Patent Number							Issue Date	Patentee	ec 2100	Sub- class	Filing Date (If Appropriate)
Alll	AA	5	2	6	1	0	6	6	11/09/93	Jouppi et al.	395	425	03/27/90
Nell	AB	5	3	1	7	7	1	8	05/31/94	Jouppi	395	425	01/25/93
All	AC	5	7	5	8	1	8	3	05/26/98	Scales	395	825	07/17/96
Dell	AD	5	7	6	1	7	2	9	06/02/98	Scales	711	148	07/17/96
All	AE	5	7	8	7	4	8	0	07/28/98	Scales et al.	711	148	07/17/96
All	AF	5	8	0	2	5	8	5	09/01/98	Scales et al.	711	154	07/17/96
Wil	AG	5	8	0	9	4	5	0	09/15/98	Chrysos et al.	702	186	11/26/97
All	AH	5	8	7	5	1	5	1	02/23/99	Mick	365	233	05/28/97
All	ΑI	5	8	9	0	2	0	1	03/30/99	McLellan et al.	711	108	07/01/97
All	AJ	5	8	9	3	9	3	1	04/13/99	Peng et al.	711	206	01/15/97
Acce	AK	5	9	1	8	2	5	0	06/29/99	Hammond	711	205	05/05/95
Da	AL	5	9	1	8	2	5	1	06/29/99	Yamada et al.	711	207	12/23/96
Dal	AM	5	9	2	3	8	7	2	07/13/99	Chrysos et al.	395	591	11/26/97
Dec	AN	5	9	5	0	2	2	8	09/07/99	Scales et al.	711	148	02/03/97
All	AO	5	9	6	4	8	6	7	10/12/99	Anderson et al.	712	219	11/26/97
ADD	AP	5	9	8	3	3	2	5	11/09/99	Lewchuk	711	137	12/09/97
Mill	AQ	6	0	0	0	0	4	4	12/07/99	Chrysos et al.	714	47	11/26/97
Alle	AR	6	0	7	0	2	2	7	05/30/2000	Rokicki	711	117	10/31/97
All	AS	6	0	8	5	3	0	0	07/04/2000	Sunaga et al.	711	168	09/19/97

		FOF	REIG	N PA	rent	OR	PUBLISHED	FOREIGN PATENT APPLIC	ATION			
]	Docur	nent N	lumbe	er	_	Publication Date	Country or Patent Office	Class	Sub- Class	Translation	
		,									Yes	No
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FORM PTO-144 (Modified)	PATENT AND TRADEMARK OFFICE	'ATTY. DOCKET NO. 1662-27800 (P00-3105)	SERIAL NO. 09/652,834
	INFORMATION DISCLOSURE STATEMENT BY APPLICANT	I Michael S BERTUNE et al	MAR
(37 CFR 1.98(b))	(Use several sheets if necessary FEB 26 2001	FILING DATE August 31, 2000	GROUP GChnology Cont
	TRADEMA		2100

OTHER DOCUMENTS (Including Author, Title, Date, Relevant Pages, Place of Publication)						
All	AT'	Alpha Architecture Reference Manual, Third Edition, The Alpha Architecture Committee, 1998 Digital Equipment Corporation (21 p.), in particular pages 3-1 through 3-15,				
All	AU	A Logic Design Structure For LSI Testability, E. B. Eichelberger et al., 1977 IEEE (Pages 462-468)				
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AOL	BA	Rambus® RIMM 7M Module (with 128/144Mb RDRAMs), Preliminary Information, Document DL0084 Version 1.1 (12 p.)				
2001	BB	Direct Rambus TM RIMM TM Module Specification Version 1.0, Rambus Inc., SL-0006-100 (32 p.), 2000				
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Examiner Wrie M Bate Schoolered 10.22.03						
EXAMINER: Initial citation considered. Draw line through citation if not in conformance and not considered. Include copy of this form with next						

communication to applicant.